

# MOSFET - Power, Single N-Channel, DUAL COOL<sup>®</sup> 80 V, 10 m $\Omega$ , 61 A

### NTMFSC011N08M7

#### **Features**

- DUAL COOL Top Side Cooling PQFN Package
- Max  $r_{DS(on)} = 10 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 10 \text{ A}$
- High Performance Technology for Extremely Low r<sub>DS(on)</sub>
- 100% UIL Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

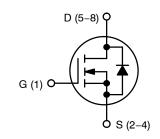
Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	80	V
Gate-to-Source Voltage	Э		V <sub>GS</sub>	±20	V
Continuous Drain	Steady State	T <sub>C</sub> = 25°C	I <sub>D</sub>	61	Α
Current R <sub>θJC</sub> (Notes 1, 3)	State	T <sub>C</sub> = 100°C		38.6	
Power Dissipation		T <sub>C</sub> = 25°C	$P_{D}$	78.1	W
R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C		31.2	
Continuous Drain	Steady State	T <sub>A</sub> = 25°C	I <sub>D</sub>	12.5	Α
Current R <sub>θJA</sub> (Notes 1, 2, 3)	State	T <sub>A</sub> = 100°C		7.9	
Power Dissipation		T <sub>A</sub> = 25°C	$P_{D}$	3.3	W
R <sub>θJA</sub> (Notes 1, 2)		T <sub>A</sub> = 100°C		1.3	
Pulsed Drain Current	$T_A = 25$	°C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	180	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C
Source Current (Body Diode)			I <sub>S</sub>	61	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 3.9 A)			E <sub>AS</sub>	640	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 1 in<sup>2</sup> pad size, 1 oz Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
80 V	10 mΩ @ 10 V	61 A

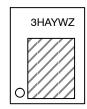
#### **N-Channel MOSFET**





DFN8 5x6 (Dual Cool 56) CASE 506EG

#### **MARKING DIAGRAM**



3H = Specific Device Code A = Assembly Location

Y = Year W = Work Week

Z = Assembly Lot Code

#### ORDERING INFORMATION

Device	Package	Shipping
NTMFSC011N08M7	DFN8 (Pb-Free)	3000 / Tape & Reel

#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	on	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•			•		
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 29	50 μΑ	80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				49		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 80 V	T <sub>J</sub> = 25°C			10	μΑ
			T <sub>J</sub> = 125°C			100	-
Zero Gate Voltage Drain Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = :	± 20 V			±100	nA
ON CHARACTERISTICS (Note 4)		-					
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 1$	20 μΑ	2.5	3.3	4.5	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-9		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A		7.6	10	mΩ
Forward Transconductance	gFS	V <sub>DS</sub> = 5 V	I <sub>D</sub> = 10 A		21.5	40	S
CHARGES, CAPACITANCES & GATE	RESISTANCE	-					
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz	V <sub>DS</sub> = 0 V		2373		pF
	C <sub>iss</sub>		V <sub>DS</sub> = 40 V		2080	2700	
Output Capacitance	C <sub>oss</sub>				286	430	-
Reverse Transfer Capacitance	C <sub>rss</sub>				11	17	
Gate Resistance	R <sub>g</sub>	V <sub>GS</sub> = 0.5 V, f = 1	1MHz		1	2	Ω
Threshold Gate Charge	Q <sub>g(th)</sub>	V <sub>GS</sub> = 0 to 2 V	V <sub>GS</sub> = 10 V,		4.3		nC
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 0 to 10 V	$V_{DS} = 40 \text{ V};$ $I_{D} = 10 \text{ A}$		29.3	38	-
Gate to Source Gate Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 0 to 10	V		11.8		-
Gate to Drain "Miller" Charge	Q <sub>gd</sub>				4.3		-
Plateau Voltage	$V_{GP}$				5.5		V
Output Charge	Q <sub>oss</sub>	V <sub>DS</sub> = 40 V <sub>,</sub> V <sub>GS</sub>	= 0 V		26		nC
SWITCHING CHARACTERISTICS (Note	e 5)						
Turn-On Delay Time	t <sub>d(ON)</sub>	V <sub>DD</sub> = 40 V, I <sub>D</sub> =	10 A,		14		ns
Turn-On Rise Time	t <sub>r</sub>	$V_{GS} = 10 \text{ V, R}_{GEN}$	= 6 Ω		6		ns
Turn-Off Delay Time	t <sub>d(OFF)</sub>				27		ns
Turn-Off Fall Time	t <sub>f</sub>				6		ns
DRAIN - SOURCE DIODE CHARACTE	RISTICS						
Source to Drain Diode Voltage	V <sub>SD</sub>	I <sub>SD</sub> = 10 A, V <sub>GS</sub> :	= 0 V		0.82	1.2	V
Reverse Recovery Time	T <sub>RR</sub>	$V_{GS} = 0 \text{ V}, dI_{SD}/dt = 100 \text{ A}/\mu\text{s},$			41	50	ns
Charge Time	ta	I <sub>S</sub> = 10 A			24.6		
Discharge Time	t <sub>b</sub>				16.1		
Reverse Recovery Charge	Q <sub>RR</sub>				45	58	nC

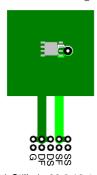
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

<sup>4.</sup> Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
5. Switching characteristics are independent of operating junction temperatures.

#### THERMAL CHARACTERISTICS

Symbol	Parameter		Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Top Source)	1.6	
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	3.0	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	27	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	16	0000
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	19	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	61	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	7
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	13	

 R<sub>θJA</sub> is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R<sub>θJA</sub> is guaranteed by design while R<sub>CA</sub> is determined by the user's board design.



a) 38°C/W when mounted on a 1 in2 pad of 2 oz copper.



b) 81°C/W when mounted on a minimum pad of 2 oz copper.

- c) Still air, 20.9·10.4·12.7 mm Aluminum Heat Sink, 1 in2 pad of 2 oz copper
- d) Still air, 20.9 10.4 12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e) Still air, 45.2-41.4-11.7 mm Aavid Thermalloy Part #10-L41B-11 Heat Sink, 1 in 2 pad of 2 oz copper
- f) Still air, 45.2-41.4-11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g) .200FPM Airflow, No Heat Sink, 1 in2 pad of 2 oz copper
- h) .200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i) .200FPM Airflow, 20.9 10.4 12.7 mm Aluminum Heat Sink, 1 in2 pad of 2 oz copper
- j) .200FPM Airflow, 20.9 10.4 12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k) .200FPM Airflow, 45.2-41.4-11.7 mm Aavid Thermalloy Part # 10 L41B 11 Heat Sink, 1 in 2 pad of 2 oz copper
- l) .200FPM Airflow, 45.2 41.4 11.7 mm Aavid Thermalloy Part # 10 L41B 11 Heat Sink, minimum pad of 2 oz copper
- 7. Pulse Test: Pulse Width < 300 \_s, Duty cycle < 2.0%.

#### **TYPICAL CHARACTERISTICS**

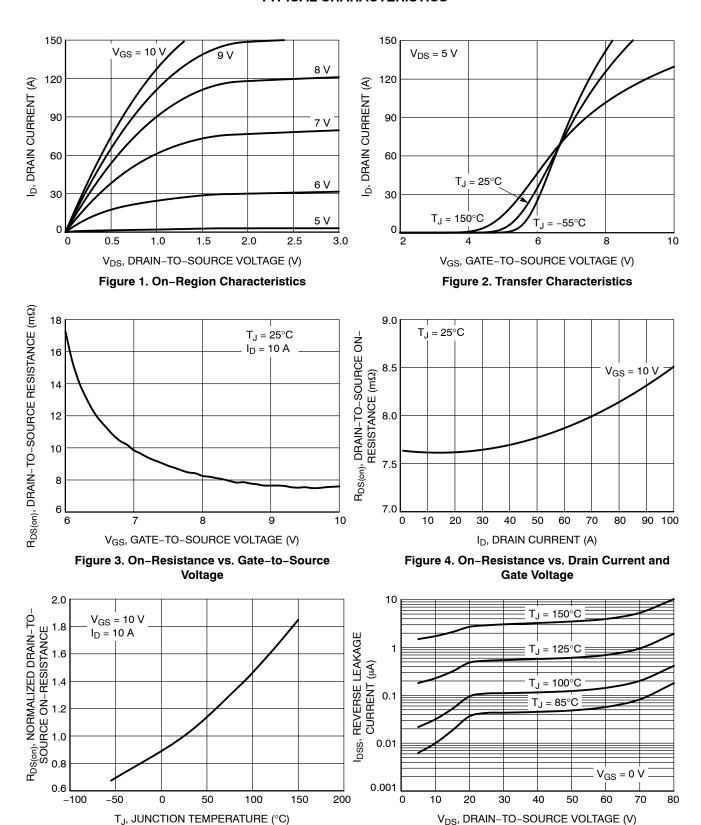


Figure 6. Drain-to-Source Leakage Current

vs. Voltage

Figure 5. On-Resistance Variation with

**Temperature** 

#### **TYPICAL CHARACTERISTICS**

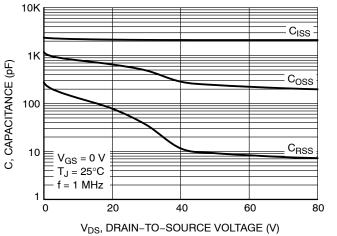


Figure 7. Capacitance Variation

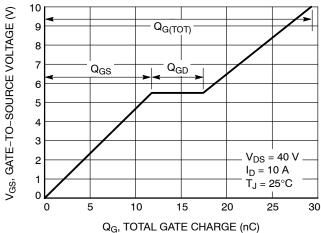


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

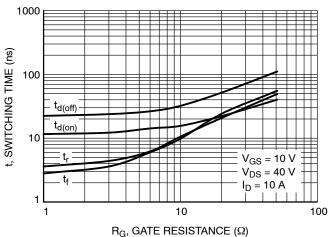


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

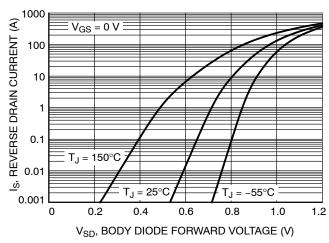


Figure 10. Diode Forward Voltage vs. Current

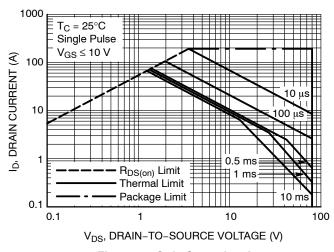


Figure 11. Safe Operating Area

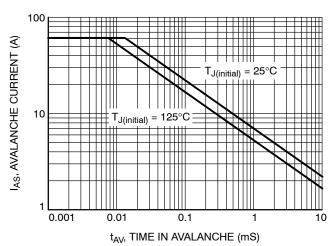


Figure 12.  $I_{\mbox{\scriptsize PEAK}}$  vs. Time in Avalanche

#### **TYPICAL CHARACTERISTICS**

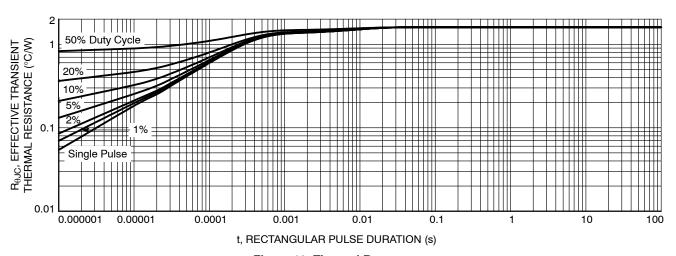


Figure 13. Thermal Response

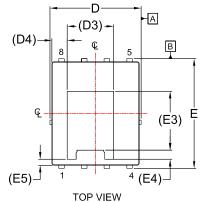
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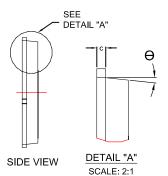


## DFN8 5x6.15, 1.27P, DUAL COOL

CASE 506EG ISSUE D

**DATE 25 AUG 2020** 





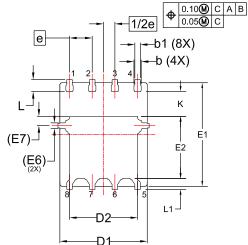
#### NOTES:

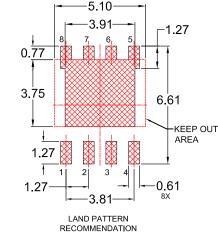
- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.

SEATING PLANE

- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS.
  "A1" IS DEFINED AS THE DISTANCE FROM THE
  SEATING PLANE TO THE LOWEST POINT ON THE
  PACKAGE BODY.

	// 0.10 C	Θ
FRONT VIEW SEE	8X A	A1 ,
DETAIL "B"	O.10 C DETAIL "B"	C





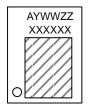
SCALE: 2:1

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRMD.

DIM	MILLIMETERS				
Divi	MIN.	NOM.	MAX.		
Α	0.85	0.90	0.95		
A1	-	-	0.05		
A2	ı	-	0.05		
b	0.31	0.41	0.51		
b1	0.21	0.31	0.41		
С	0.20	0.25	0.30		
D	4.90	5.00	5.10		
D1	4.80	4.90	5.00		
D2	3.67	3.82	3.97		
D3	2.60 REF				
D4	0.86 REF				
E	6.05	6.15	6.25		
E1	5.70	5.80	5.90		
E2	3.38	3.48	3.58		
E3	•	3.30 REF			
E4	Ī	0.50 REF			
E5	Û	0.34 REF	:		
E6	0.30 REF				
E7	0.52 REF				
е	1.27 BSC				
1/2e	0.635 BSC				
K	1.30	1.40	1.50		
L	0.56	0.66	0.76		
L1	0.52	0.62	0.72		
θ	0°		12°		

# GENERIC MARKING DIAGRAM\*

**BOTTOM VIEW** 



XXXX = Specific Device Code

A = Assembly Location

Y = Year

WW = Work Week

ZZ = Assembly Lot Code

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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